Rev. 2.0

## 2<sup>nd</sup>Generation thinQ!<sup>™</sup> SiC Schottky Diode

### Features

infineon

- Revolutionary semiconductor material Silicon Carbide
- Switching behavior benchmark
- No reverse recovery/ No forward recovery
- No temperature influence on the switching behavior
- High surge current capability
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Breakdown voltage tested at 5mA<sup>2)</sup>

## thinQ! 2G Diode specially designed for fast switching applications like:

- CCM PFC
- Motor Drives

Туре	Package	Marking	Pin 1	Pin 2
IDH08S60C	PG-TO220-2	D08S60C	С	А

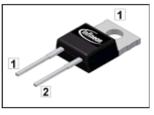
**Maximum ratings,** at  $T_i$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous forward current	I <sub>F</sub>	<i>T</i> <sub>C</sub> <140 °C	8	А
RMS forward current	I <sub>F,RMS</sub>	f=50 Hz	12	
Surge non-repetitive forward current, sine halfwave	/ <sub>F,SM</sub>	T <sub>C</sub> =25 °C, t <sub>p</sub> =10 ms	59	
Repetitive peak forward current	I <sub>F,RM</sub>	T <sub>j</sub> =150 °C, T <sub>C</sub> =100 °C, D=0.1	32	
Non-repetitive peak forward current	I <sub>F,max</sub>	T <sub>C</sub> =25 °C, t <sub>p</sub> =10 μs	264	
<i>i</i> <sup>2</sup> <i>t</i> value	∫i²dt	T <sub>C</sub> =25 °C, <i>t</i> <sub>p</sub> =10 ms	17	A <sup>2</sup> s
Repetitive peak reverse voltage	$V_{\text{RRM}}$		600	V
Diode dv/dt ruggedness	d <i>v</i> ∕dt	V <sub>R</sub> = 0480V	50	V/ns
Power dissipation	P <sub>tot</sub>	7 <sub>с</sub> =25 °С	75	W
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>		-55 175	°C
Mounting torque		M3 and M3.5 screws	60	Mcm
Soldering temperature, wavesoldering only allowed at leads	${\cal T}_{\rm sold}$	1.6mm (0.063 in.) from case for 10s	260	°C

#### Product Summary

V <sub>DC</sub>	600	V
Q <sub>c</sub>	19	nC
l <sub>F</sub>	8	А







Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$		-	-	2	K/W
Thermal resistance, junction - ambient	$R_{\mathrm{thJA}}$	leaded	-	-	62	

#### Electrical characteristics, at $T_j$ =25 °C, unless otherwise specified

#### **Static characteristics**

DC blocking voltage	V <sub>DC</sub>	/ <sub>R</sub> =0.1 mA	600	-	-	V
Diode forward voltage	V <sub>F</sub>	I <sub>F</sub> =8 A, <i>T</i> <sub>j</sub> =25 °C	-	1.5	1.7	
		I <sub>F</sub> =8 A, <i>T</i> <sub>j</sub> =150 °C	-	1.7	2.1	
Reverse current	/ <sub>R</sub>	V <sub>R</sub> =600 V, <i>T</i> <sub>j</sub> =25 °C	-	1	100	μA
		V <sub>R</sub> =600 V, <i>T</i> <sub>j</sub> =150 °C	-	4	1000	

#### AC characteristics

Total capacitive charge	Q <sub>c</sub>	V <sub>R</sub> =400 V,I <sub>F</sub> ≤I <sub>F,max</sub> , d <i>i<sub>F</sub></i> /d <i>t</i> =200 A/µs,	-	19	-	nC
Switching time <sup>3)</sup>	t <sub>c</sub>	dr <sub>j</sub> =150 °C	-	-	<10	ns
Total capacitance	С	V <sub>R</sub> =1 V, <i>f</i> =1 MHz	-	310	-	pF
		V <sub>R</sub> =300 V, <i>f</i> =1 MHz	-	50	-	
		V <sub>R</sub> =600 V, <i>f</i> =1 MHz	-	50	-	

#### <sup>1)</sup> J-STD20 and JESD22

 $^{2)}\mbox{All}$  devices tested under avalanche conditions, for a time periode of 5ms, at 5 mA.

<sup>3)</sup>  $t_c$  is the time constant for the capacitive displacement current waveform (independent from  $T_j$ ,  $I_{LOAD}$  and di/dt), different from  $t_{rr}$  which is dependent on  $T_j$ ,  $I_{LOAD}$  and di/dt. No reverse recovery time constant  $t_{rr}$  due to absence of minority carrier injection.

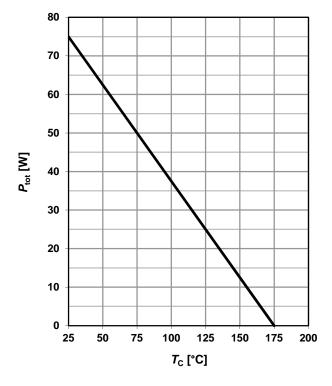
<sup>4)</sup> Only capacitive charge occuring, guaranteed by design



#### **1 Power dissipation**

 $P_{tot}=f(T_C)$ 

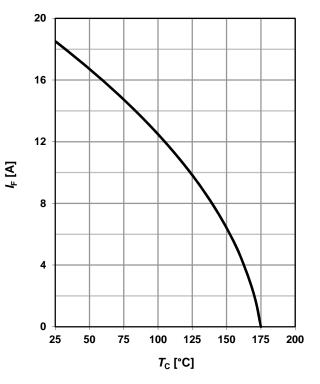
parameter: R<sub>thJC(max)</sub>



#### 2 Diode forward current

 $I_{\rm F}$ =f( $T_{\rm C}$ );  $T_{\rm j}$ ≤175 °C

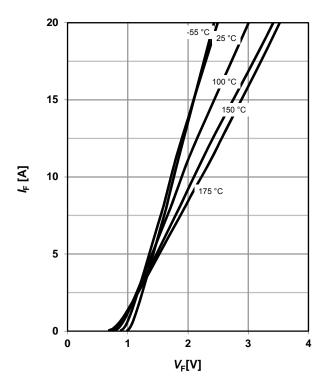
parameter:  $R_{thJC(max)}$ ;  $V_{F(max)}$ 



#### 3 Typ. forward characteristic

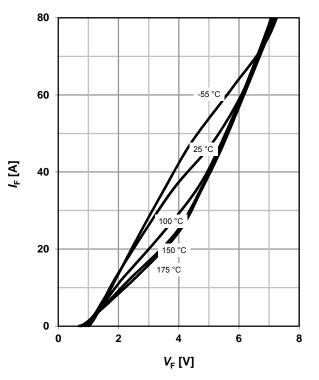
 $I_{\rm F}$ =f( $V_{\rm F}$ );  $t_{\rm p}$ =400 µs

parameter: T<sub>j</sub>



# 4 Typ. forward characteristic in surge current mode

 $I_{\rm F}$ =f( $V_{\rm F}$ );  $t_{\rm p}$ =400 µs; parameter:  $T_{\rm j}$ 

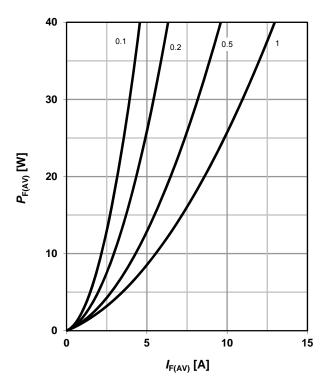




#### 5 Typ. forward power dissipation vs.

#### average forward current

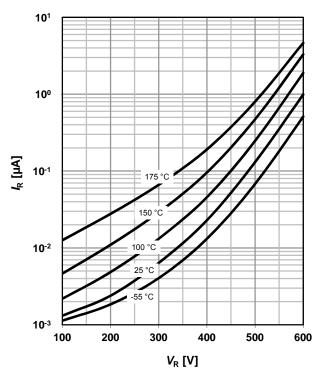
 $P_{F,AV}=f(I_F)$ ,  $T_C=100$  °C, parameter:  $D=t_p/T$ 



#### 6 Typ. reverse current vs. reverse voltage

 $I_{\rm R}$ =f( $V_{\rm R}$ )

parameter:  $T_j$ 



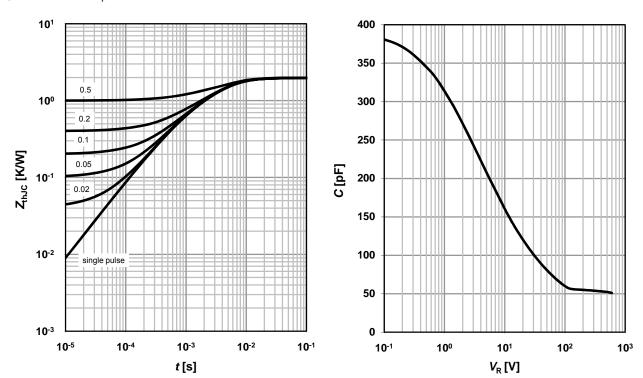
8 Typ. capacitance vs. reverse voltage

 $C=f(V_R)$ ;  $T_C=25$  °C, f=1 MHz

#### 7 Transient thermal impedance

 $Z_{\text{thJC}}=f(t_p)$ 

parameter:  $D = t_p/T$ 



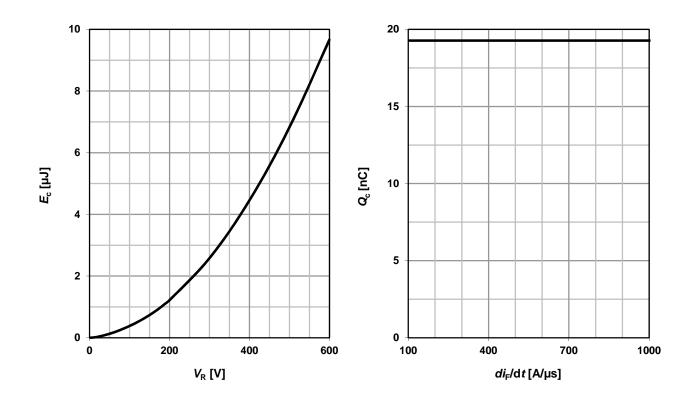


#### 9 Typ. C stored energy

## 10 Typ. capacitance charge vs. current slope

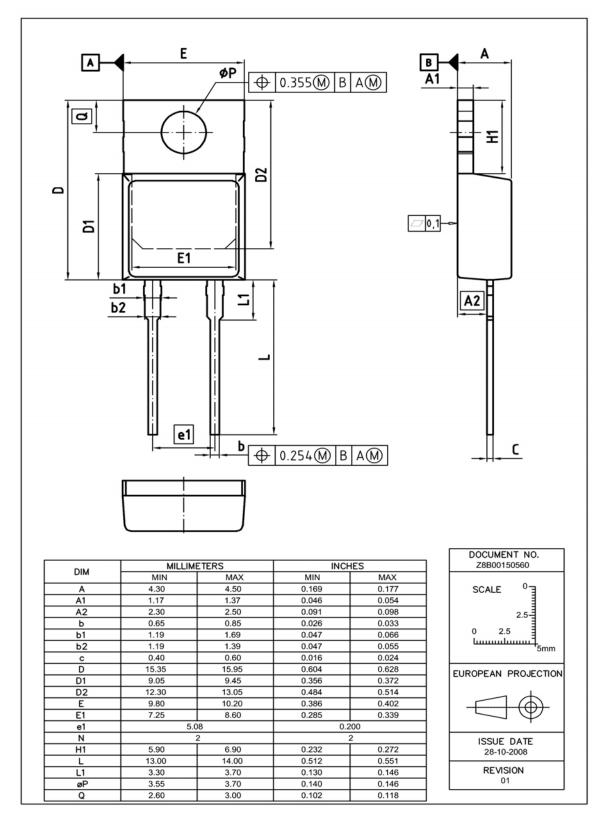
 $E_{\rm C}$ =f( $V_{\rm R}$ )

 $Q_{C} = f(di_{F}/dt)^{4}; T_{j} = 150 \text{ °C}; I_{F} \leq I_{F,max}$ 





#### PG-TO220-2: Outline



Dimensions in mm/inches

Downloaded from Arrow.com.





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